

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-029001	Application No. 09/833,673
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei YAMAZAKI et al.	
		Filing Date April 13, 2001	Group Art Unit 2673

## U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
01/11/01	AA	5,882,761	03/16/1999	Kawami et al.			
01/11/01	AB	5,990,629	11/23/1999	Yamada et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
A.M.	AL	09-148066	6/1997	Japanese				
A.M.	AM	10-214060	8/1998	Japanese				
A.M.	AN	10-232649	9/1998	Japanese				
	AO							
	AP							

## Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	<del>Japanese Patent Application Laid-Open No. 09-148066 (English Abstract attached)</del>
	AR	<del>Japanese Patent Application Laid-Open No. 10-214060 (English Abstract attached)</del>
	AS	<del>Japanese Patent Application Laid-Open No. 10-232649 (English Abstract attached)</del>

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Patent and Trademark OfficeAttorney's Docket No.  
12732-029001

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Application No.  
09/833,673**Information Disclosure Statement  
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant  
Shunpei YAMAZAKI, et alFiling Date  
April 13, 2001Group Art Unit  
2673**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
A.M	AL	TW 250560	07/01/1995	Taiwan	—	—	ABS	
	AM							
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

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	AQ	
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	AS	
	AT	

Examiner Signature

*Anne M. [Signature]*

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